Notice of References Cited Application/Control No. 10/535,176 Examiner Deborah Yee Applicant(s)/Patent Under Reexamination BEGUINOT ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
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	G	US-			
	Н	US-			
	ı	US-		W-W	
	J	US-			
	К	US-			
11-1	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2000-239791	09-2000	Japan	Yashuara, Hideko	
	0					
	Р					
	Q					
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NON-PATENT DOCUMENTS

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